## NSN 6625-01-034-0940

Fiig: T228-a

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View Online at https://aerobasegroup.com/nsn/6625-01-034-0940 Width: 11.200 inches Ac Voltage Rating: Between 117.0 volts and 234.0 volts Frequency Rating: Between 50.0 hertz and 60.0 hertz Depth: 12.200 inches **Electrical Power Source Relationship:** Operating **Internal Battery Accommodation:** Not included **Inclosure Feature:** Single item w/housing **Test Type For Which Designed:** Evaluate digital integrated circuits **Operating Test Capability:** Data setup time 230/800 ns; clockpulse width 140/440 ns; output settling time 630/2760 ns Phase: Single Height: 5.900 inches Shelf Life: N/a **Unit Of Measure: Demilitarization:** No